

<b>Notice of References Cited</b>	Application/Control No. 10/085,393	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,276,747 A	01-1994	Pan, Jing-Jong	385/34
	B	US-5,315,431 A	05-1994	Masuda et al.	359/281
	C	US-6,023,542 A	02-2000	Pan et al.	385/24
	D	US-6,055,104 A	04-2000	Cheng, Yihao	359/495
	E	US-6,181,846 B1	01-2001	Pan, Jing-Jong	385/18
	F	US-6,195,479 B1	02-2001	Pan, Jing-Jong	385/18
	G	US-6,198,567 B1	03-2001	Bergmann, Ernest Eisenhardt	359/281
	H	US-6,266,474 B1	07-2001	Han et al.	385/140
	I	US-6,441,944 B1	08-2002	Kim et al.	359/281
	J	US-6,483,982 B1	11-2002	Takahashi, Mitsuo	385/140
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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